

N-Ch MOSFET

General Description

The WSF60120 is the highest performance SGT N-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSF60120 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

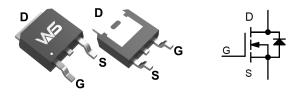
Product Summery

BVDSS	RDSON	ID
60V	3.0mΩ	110A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- LCD/LED back light

TO-252 Pin Configuration



Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	60	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	110	А
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ 10V ¹	66	А
I _{DM}	Pulsed Drain Current ²	240	А
EAS	Single Pulse Avalanche Energy ³	101	mJ
I _{AS}	Avalanche Current	45	А
P _D @T _C =25℃	Total Power Dissipation ⁴	83	W
P _D @T _A =25℃	Total Power Dissipation ⁴	2.5	W
T _{STG}	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹		55	°C/W
R _{eJC}	Thermal Resistance Junction-Case ¹		1.5	°C/W

Absolute Maximum Ratings



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$, I_D=1mA		0.057		V/℃
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =20A		3.0	3.6	mΩ
		V _{GS} =4.5V , I _D =15A.		4.4	5.4	
V _{GS(th)}	Gate Threshold Voltage		1.2		2.3	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	— V _{GS} =V _{DS} , I _D =250uA		-5.68		mV/℃
	Drain-Source Leakage Current	$V_{\text{DS}}\text{=}48\text{V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^\circ\!\mathrm{C}$			1	
I _{DSS}		V_{DS} =48V , V_{GS} =0V , T_{J} =55 $^{\circ}\mathrm{C}$			5	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =20A		65		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		0.7	1.0	Ω
Qg	Total Gate Charge (4.5V)	V _{DS} =30V , V _{GS} =4.5V , I _D =20A		58		nC
Q _{gs}	Gate-Source Charge			16		
Q _{gd}	Gate-Drain Charge			4		
T _{d(on)}	Turn-On Delay Time	V _{DD} =30V , V _{GS} =10V , R _G =3Ω, RL=1.5Ω.		18		
Tr	Rise Time			8		
T _{d(off)}	Turn-Off Delay Time			50		ns
T _f	Fall Time			10.5		
Ciss	Input Capacitance	V _{DS} =30V , V _{GS} =0V , f=1MHz		3458		
C _{oss}	Output Capacitance			1522		pF
C _{rss}	Reverse Transfer Capacitance			22		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	$V_G = V_D = 0V$, Force Current			55	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , TJ=25℃			1.3	V
t _{rr}	Reverse Recovery Time			24		nS
Qrr	Reverse Recovery Charge	IF=20A ,dl/dt=100A/µs,Tյ=25℃		85		nC

Note :

1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3. The EAS data shows Max. rating . The test condition is $V_{\text{DD}}\text{=}25\text{V}, V_{\text{GS}}\text{=}10\text{V}, \text{L=}0.1\text{mH}, \text{I}_{\text{AS}}\text{=}60\text{A}$

4.The power dissipation is limited by 150 $^\circ\!\!\mathbb{C}$ junction temperature

5.The Min. value is 100% EAS tested guarantee.

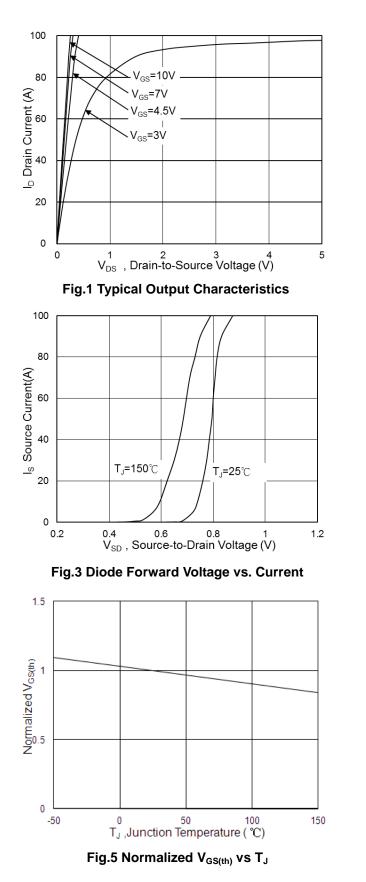
6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

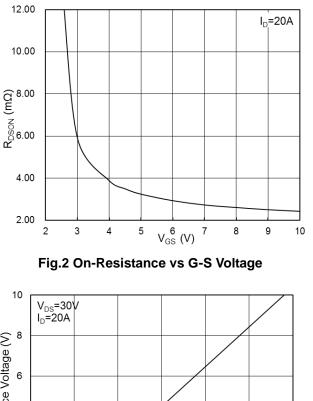


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Typical Characteristics





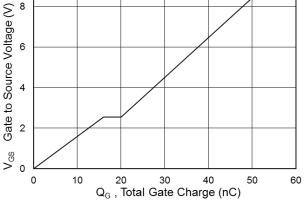
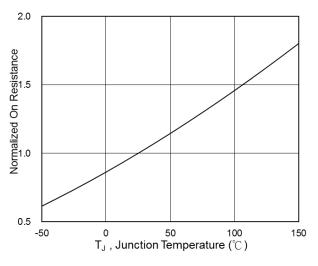


Fig.4 Gate-Charge Characteristics







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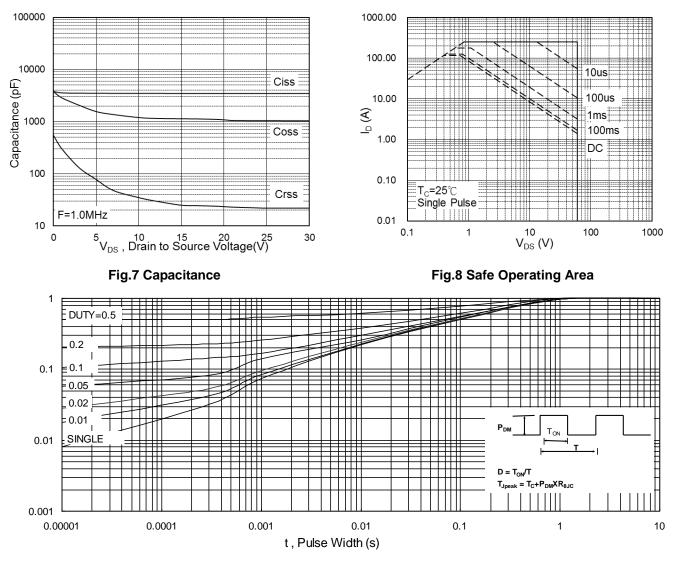
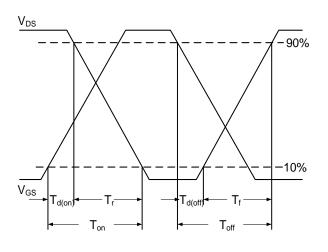


Fig.9 Normalized Maximum Transient Thermal Impedance





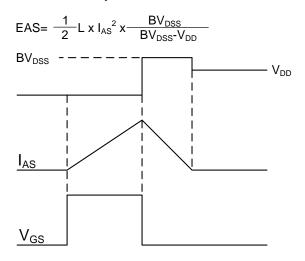


Fig.11 Unclamped Inductive Switching Waveform



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